



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

**In re Application of**

Young Hoon Kwark

**Serial No.:** 10/827,230

**Group Art Unit:** 2858

**Filed:** April 20, 2004

**Examiner:** Teresinski, J.

**For:** METHOD AND STRUCTURE FOR VARIABLE PITCH MICROWAVE PROBE ASSEMBLY

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**AMENDMENT UNDER 37 C.F.R. §1.111**

Sir:

In response to the Office Action dated February 16, 2006, please amend the above-identified application as follows:

**Amendments to the Claims** are reflected in the listing of claims, which begins on page 2 of this paper.

The claim amendments for claims 1 and 18 are supported in the specification at line 16 of page 1, lines 17-23 of page 2, lines 1-5 and lines 13-15 of page 3, lines 1-3 of page 4, lines 10-14 of page 5, lines 15-18 of page 6, and lines 3-4 of page 8.

The claim amendment to claims 9 and 23 and new claim 26 are supported at lines 10-14 of page 7 and lines 2-5 of page 10.

**Amendments to the Drawings** are reflected on page 8 of this paper.

**Remarks** begin on page 9 of this paper.

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